

## **Search Notes**



**Application/Control No.**

10/710.581

Examiner

Tuan H. Nguyen

**Applicant(s)/Patent under  
Reexamination**

HWANG ET AL.

## **Art Unit**

2813

**SEARCHED**

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner